



TEST REPORT

No. I22Z70452-EMC12

for

Samsung Electronics Co., Ltd.

Notebook PC

Model name: NP750XFH, NP754XFH, NP750XFS, NP754XFS

With

FCC ID: ZCANP750XFH

Hardware Version: REV1.0

Software Version: Windows 11

Issued Date: 2022-12-07

Note:

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The report must not be used by the client to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the U.S. Government.

Test Laboratory:

CTTL-Telecommunication Technology Labs, CAICT

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REPORT HISTORY

Report Number	Revision	Description	Issue Date
I22Z70452-EMC12	Rev.0	1 st edition	2022-12-07

Note: the latest revision of the test report supersedes all previous versions.

CONTENTS

1. TEST LABORATORY.....	4
1.1. INTRODUCTION & ACCREDITATION	4
1.2. TESTING LOCATION	4
1.3. TESTING ENVIRONMENT	4
1.4. PROJECT DATA.....	4
1.5. SIGNATURE	4
2. CLIENT INFORMATION.....	5
2.1. APPLICANT INFORMATION	5
2.2. MANUFACTURER INFORMATION	5
3. EQUIPMENT UNDER TEST (EUT) AND ANCILLARY EQUIPMENT (AE).....	6
3.1. ABOUT EUT	6
3.2. INTERNAL IDENTIFICATION OF EUT USED DURING THE TEST.....	6
3.3. INTERNAL IDENTIFICATION OF AE USED DURING THE TEST	6
3.4. EUT SET-UPS.....	7
4. REFERENCE DOCUMENTS	8
4.1. REFERENCE DOCUMENTS FOR TESTING	8
5. LABORATORY ENVIRONMENT	9
6. SUMMARY OF TEST RESULTS	10
7. TEST EQUIPMENTS UTILIZED	11
ANNEX A: MEASUREMENT RESULTS.....	12
ANNEX B: PERSONS INVOLVED IN THIS TESTING.....	27

1. Test Laboratory

1.1. Introduction & Accreditation

Telecommunication Technology Labs, CAICT is an ISO/IEC 17025:2017 accredited test laboratory under NATIONAL VOLUNTARY LABORATORY ACCREDITATION PROGRAM (NVLAP) with lab code 600118-0, and is also an FCC accredited test laboratory (CN5017), and ISED accredited test laboratory (ISED#: 24849). The detail accreditation scope can be found on NVLAP website.

1.2. Testing Location

CTTL (Huayuan North Road)

Address: No. 52 Huayuan North Road, Haidian District, Beijing 100191, P.R. China

1.3. Testing Environment

Normal Temperature: 15-35°C

Relative Humidity: 20-75%

1.4. Project data

Testing Start Date: 2022-11-01

Testing End Date: 2022-12-06

1.5. Signature



Li Yan

(Prepared this test report)



Zhang Ying

(Reviewed this test report)



Zhang Xia

Deputy Director of the laboratory

(Approved this test report)



2. Client Information

2.1. Applicant Information

Company Name: Samsung Electronics Co., Ltd.
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City: /
Postal Code: /
Country: /
Contact: Jenni Chun
Email: j1.chun@samsung.com
Telephone: +1-201-937-4203

2.2. Manufacturer Information

Company Name: Samsung Electronics. Co., Ltd.
Address: Samsung R5, Maetan dong 129, Samsung ro
Youngtong gu, Suwon city 443 742, Korea
City: /
Postal Code: /
Country: /
Contact: Sunghoon Cho
Email: ggobi.cho@samsung.com
Telephone: +82-10-2722-4159

3. Equipment Under Test (EUT) and Ancillary Equipment (AE)

3.1. About EUT

Description	Notebook PC
Model name	NP750XFH, NP754XFH, NP750XFS, NP754XFS
FCC ID	ZCANP750XFH

Note: Components list, please refer to documents of the manufacturer; it is also included in the original test record of CTTL, Telecommunication Technology Labs, CAICT.

3.2. Internal Identification of EUT used during the test

EUT ID*	IMEI/SN	HW Version	SW Version
EUT1	2270452UT18a	REV1.0	Windows 11
EUT2	2270452UT19a	REV1.0	Windows 11
EUT3	2270452UT24a	REV1.0	Windows 11
EUT4	2270452UT28a	REV1.0	Windows 11

*EUT ID: is used to identify the test sample in the lab internally.

3.3. Internal Identification of AE used during the test

AE ID*	Description	SN	Remarks
AE1	Adapter	/	EP-TA865
AE2	HDMI Cable	/	/
AE3	Display	/	/
AE4	Mobile HD	/	USB
AE5	Mobile HD	/	USB
AE6	Mobile HD	/	Type-C
AE7	SD card	/	/
AE8	Headset	/	/
AE9	Data Cable	/	/
AE10	Battery	/	/

Note: The USB cables are shielded.

3.4. General Description

Equipment under Test (EUT) is a model of Notebook PC with integrated antenna.

It consists of normal options: lithium battery and charger.

Samples undergoing test were selected by the client.

The differences in the model names are only for different marketing purposes.

Manual and specifications of the EUT were provided to fulfil the test.

For more EUT information please refers to the manufacturer's specifications or user's manual.

3.5. Key component list

Item	Spec.	Vendor	Vendor Model
CPU	Intel 13th Gen Raptor lake-P i7,U28	Intel	INTEL(R) CORE(TM) PROCESSOR i7-1360P
	Intel 13th Gen Raptor lake-P i5,U28		INTEL(R) CORE(TM) PROCESSOR i5-1340P
WLAN	802.11 ax 2x2		AX201D2W
GPU	DG2	Intel	FD8071104610736
VRAM	GDDR6 4GB	Samsung Electronics Co.,Ltd. (SAMSUNG)	K4ZAF325BC-SC16
Memory	LPDDR4x 8GB	Samsung Electronics Co.,Ltd. (SAMSUNG)	K4U6E3S4AB-MGCL
	LPDDR4x 16GB	Samsung Electronics Co.,Ltd. (SAMSUNG)	K4UBE3D4AB-MGCL
SSD	256G M.2 2280 PCIe(NVMe)	Samsung Electronics Co.,Ltd. (SAMSUNG)	MZVLQ256HBJD-00B
		SOLID STATES STORAGE TECHNOLOGY CORPORATION	CL1-8D256
	512G M.2 2280 PCIe(NVMe)	Samsung Electronics Co.,Ltd. (SAMSUNG)	MZVLQ512HBLU-00B
	512G M.2 2230 PCIe(NVMe)	Samsung Electronics Co.,Ltd. (SAMSUNG)	MZ9LQ512HBLU-00BKN
	1TB M.2 2280 PCIe(NVMe)	Samsung Electronics Co.,Ltd. (SAMSUNG)	MZVLQ1T0HBLB-00B
Western Digital (WD)		SDBPNPZ-1T00	
LCD	15.6" FHD IPS	BOE Optoelectronics Technology Co., Ltd	NE156FHM-NS0
		BengBu K&D Technology Co.,Ltd	KD156N20-30NI-A003.
Battery	54W	SDI	AA-PBSN4AT
Mouse	Black	Acrox	AA-MW1D5WB
Antenna	/	INNOWAVE	/
	/	SPEED	/

Note: EUT1, EUT2, EUT3 and EUT4 correspond to the configurations of different key components.

3.6. EUT set-ups

EUT set-up No.	Combination of EUT and AE	Remarks
Set.1	EUT1+AE1 +AE2+AE3+AE4+AE5+AE6+AE7+AE8+AE9	EUT1+ Adapter1
Set.2	EUT2+AE1 +AE2+AE3+AE4+AE5+AE6+AE7+AE8+AE9	EUT2+ Adapter1
Set.3	EUT3+AE1 +AE2+AE3+AE4+AE5+AE6+AE7+AE8+AE9	EUT3+ Adapter1
Set.4	EUT4+AE1 +AE2+AE3+AE4+AE5+AE6+AE7+AE8+AE9	EUT4+ Adapter1

4. Reference Documents

4.1. Documents supplied by applicant

EUT parameters are supplied by the client or manufacturer, which is the basis of testing.

4.2. Reference Documents for testing

The following documents listed in this section are referred for testing.

Reference	Title	Version
FCC 47 CFR Part 15, Subpart B	Radio frequency devices - Unintentional Radiators	2020
ANSI C63.4	American National Standard for Methods of Measurement of Radio-Noise Emissions from Low-Voltage Electrical and Electronic Equipment in the Range of 9 kHz to 40 GHz	2014

Note: The test methods have no deviation with standards.

5. LABORATORY ENVIRONMENT

Semi-anechoic chamber SAC did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 15 %, Max. = 75 %
Shielding effectiveness	0.014MHz - 1MHz, >60dB; 1MHz - 1000MHz, >90dB.
Electrical insulation	> 2 M Ω
Ground system resistance	< 4 Ω
Normalised site attenuation (NSA)	< \pm 4 dB, 3m distance, from 30 to 1000 MHz
Site voltage standing-wave ratio (S_{VSWR})	Between 0 and 6 dB, from 1GHz to 18GHz
Uniformity of field strength	Between 0 and 6 dB, from 80 to 6000 MHz

Shielded room did not exceed following limits along the EMC testing:

Temperature	Min. = 15 °C, Max. = 35 °C
Relative humidity	Min. = 20 %, Max. = 75 %
Shielding effectiveness	0.014MHz-1MHz, >60dB; 1MHz – 1000MHz, >90dB.
Electrical insulation	> 2 M Ω
Ground system resistance	< 4 Ω

6. SUMMARY OF TEST RESULTS

Abbreviations used in this clause:		
Verdict Column	P	Pass
	NA	Not applicable
	F	Fail
	BR	Re-use test data from basic model report.

Items	Test Name	Clause in FCC rules	Section in this report	Verdict	Test Location
1	Radiated Emission	15.109(a)	A.1	P	CTTL(Huayuan North Road)
2	Conducted Emission	15.107(a)	A.2	P	CTTL(Huayuan North Road)

7. Test Equipments Utilized

Test Equipment

NO.	Description	TYPE	SERIES NUMBER	MANUFACTURE	CAL DUE DATE	CALIBRATION INTERVAL
1	Test Receiver	ESCI3	100344	R&S	2023-02-21	1 year
2	LISN	ENV216	101200	R&S	2023-05-30	1 year
3	Test Receiver	ESW44	103015	R&S	2023-02-23	1 year
4	Test Receiver	ESU26	100235	R&S	2023-03-08	1 year
5	EMI Antenna	3115	00167250	R&S	2023-06-20	1 year
6	EMI Antenna	VULB9163	01223	Schwarzbeck	2023-07-25	1 Year

Test Software

Test Item	Test Software and Version	Software Vendor
Radiated Continuous Emission	EMC32 V10.60.20	R&S
Conducted Emission	EMC32 V10.60.20	R&S

ANNEX A: MEASUREMENT RESULTS

A.1 Radiated Emission

Reference

FCC: CFR Part 15.109(a).

A.1.1 Method of measurement

The field strength of radiated emissions from the unintentional radiator at distances of 10 meters (for 30MHz-1GHz) and 3 meters (for above 1GHz) is tested. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 8.3.

The EUT was placed on a non-conductive table and arranged in a typical configuration in accordance with ANSI C63.4-2014 and manipulated to obtain worst case emissions. The measurement antenna was placed at a distance of 3 /10 meters from the EUT. During the tests, the antenna height and the EUT azimuth were varied in order to identify the maximum level of emissions from the EUT.

For the test setup photographs please see the test setup photos document.

A.1.2 EUT Operating Mode

The EUT exercise program was tested using the Burn-in test program for windows.

The system was configured for testing in a typical mode that a customer would normal use.

Cables were attached to each of the available I/O ports. Where applicable, peripherals were attached to the I/O cables. All the external I/O ports were exercised.

LABTM software is used to let the EUT to continuously copy data to external (Hard Disk & SD card) storage media, read and erase the data after copy action was finished. During the test, the a pattern of "H" characters was written to display on the LCD panel; the camera was in video mode; the music was repetitively played through the headset; the WIFI and BT function was on and worked in receiver mode.

A.1.3 Measurement Limit

Frequency range (MHz)	Field strength limit ($\mu\text{V}/\text{m}$)		
	Quasi-peak	Average	Peak
30-88	100		
88-216	150		
216-960	200		
960-1000	500		
>1000		500	5000

Note: the above limit is for 3 meters test distance. 10 meters' limit is got by converting.

Limit (10m) = limit (3m) + 20(log (3/10))

A.1.4 Test Condition

Voltage (V)	Frequency (Hz)
120	60

Frequency range (MHz)	RBW/VBW	Sweep Time (s)	Detector
30-1000	120kHz (IF Bandwidth)	5	Peak/Quasi-peak
Above 1000	1MHz/3MHz	15	Peak, Average

A.1.5 Measurement Results

A "reference path loss" is established and the A_{Rpl} is the attenuation of "reference path loss". It includes the antenna factor of receive antenna and the path loss.

The measurement results are obtained as described below:

$$\text{Result} = P_{\text{Mea}} + A_{\text{Rpl}} = P_{\text{Mea}} + G_A + G_{\text{PL}}$$

Where

G_A : Antenna factor of receive antenna

G_{PL} : Path Loss

P_{Mea} : Measurement result on receiver.

Measurement uncertainty (worst case): 30MHz-1GHz: 5.15dB, 1GHz-18GHz: 5.54dB, $k=2$.

Set.1

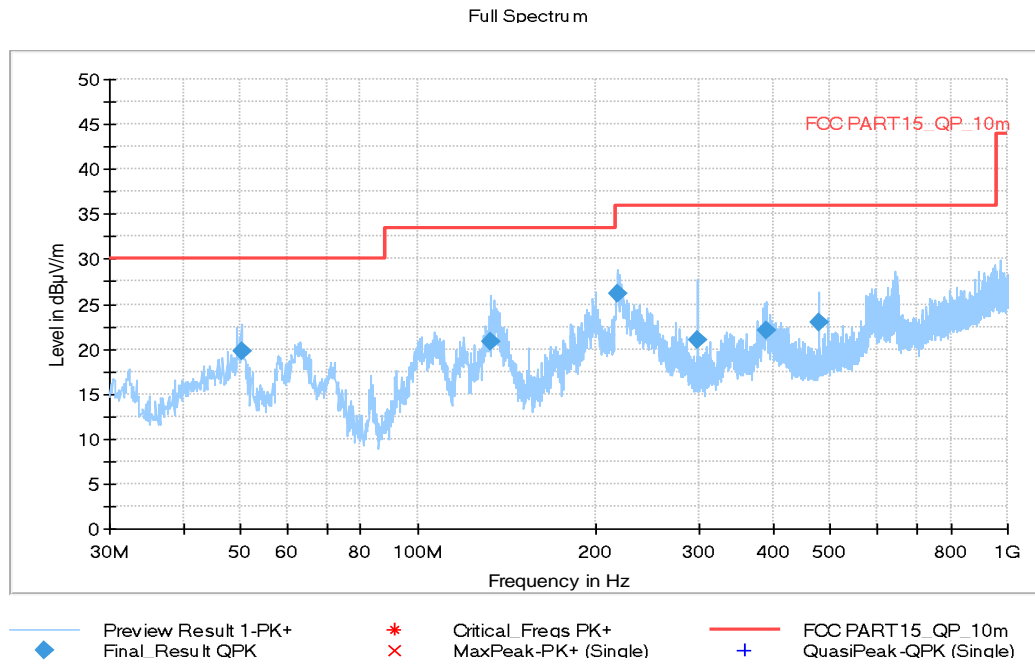


Figure A.1 Radiated Emission from 30MHz to 1GHz

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)
50.17600	19.67	30.00	10.33	120.000	108.0	V	36.0
132.7230	20.89	33.52	12.63	120.000	125.0	V	-44.0
217.8890	26.17	36.02	9.85	120.000	108.0	V	163.0
296.9440	21.06	36.02	14.96	120.000	125.0	V	266.0
389.9670	22.11	36.02	13.91	120.000	287.0	H	45.0
479.9830	22.95	36.02	13.07	120.000	186.0	H	315.0

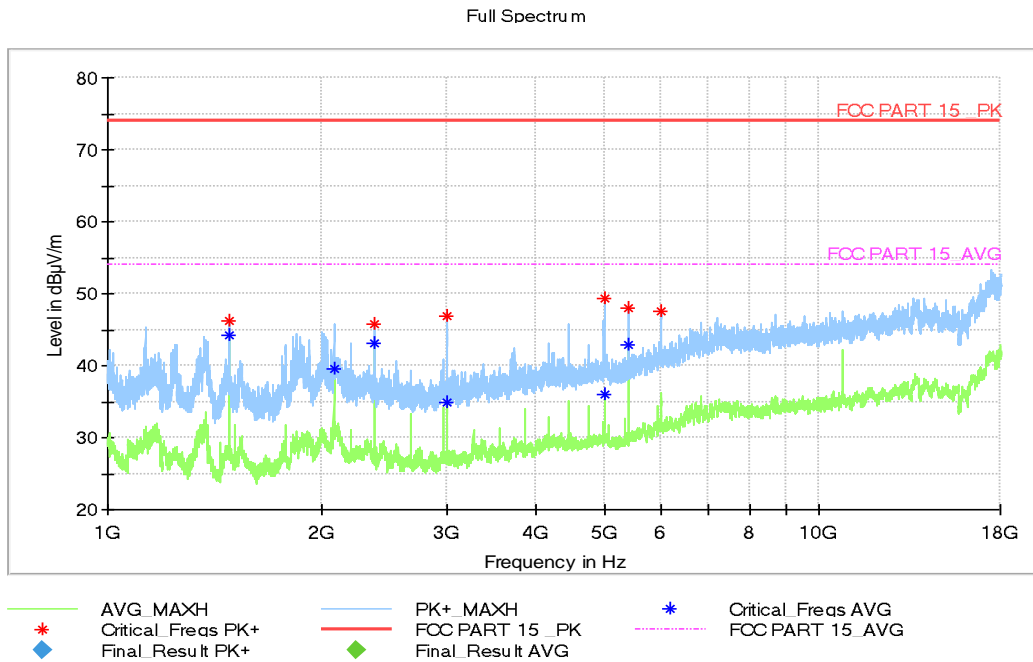


Figure A.2 Radiated Emission from 1GHz to 18GHz

Average detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
2375.980000	43.03	54.00	10.97	1000.000	100.0	V	270.0
5399.940000	42.86	54.00	11.14	1000.000	100.0	V	90.0
2078.820000	39.63	54.00	14.37	1000.000	100.0	V	180.0
2998.860000	34.94	54.00	19.06	1000.000	100.0	V	270.0
1484.840000	44.25	54.00	9.75	1000.000	100.0	H	90.0
4998.400000	36.02	54.00	17.98	1000.000	200.0	H	180.0

Peak detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
2375.980000	45.79	74.00	28.21	1000.000	100.0	V	270.0
1484.500000	46.16	74.00	27.84	1000.000	100.0	H	90.0
2997.840000	46.83	74.00	27.17	1000.000	100.0	V	270.0
5999.700000	47.51	74.00	26.49	1000.000	100.0	V	180.0
5399.940000	48.08	74.00	25.92	1000.000	100.0	V	90.0
4990.580000	49.30	74.00	24.70	1000.000	200.0	H	180.0

Set.2

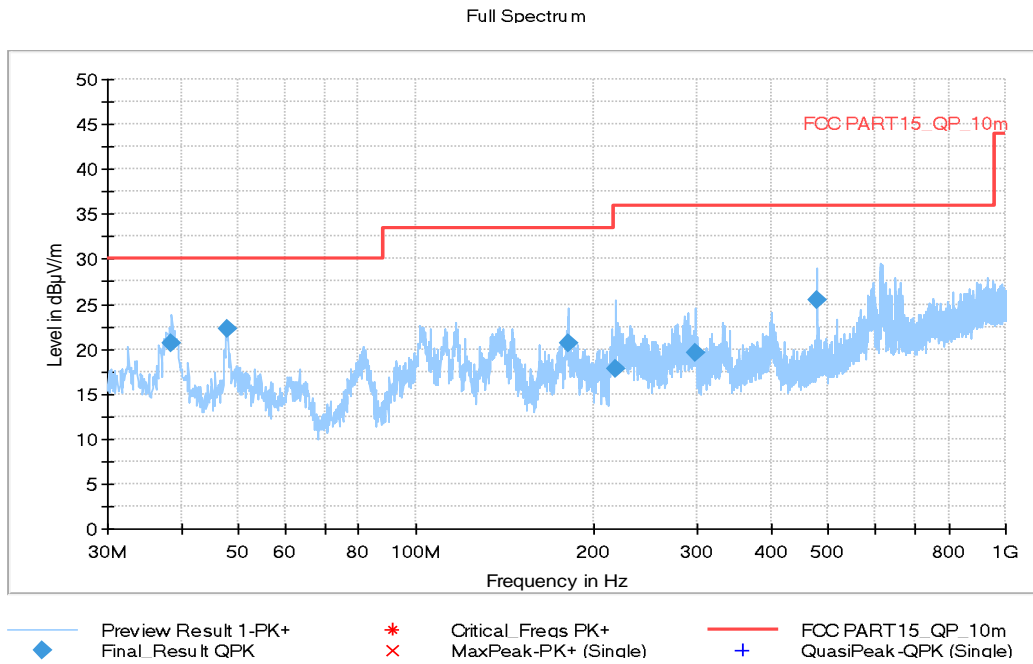


Figure A.3 Radiated Emission from 30MHz to 1GHz

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)
38.53600	20.64	30.00	9.36	120.000	223.0	V	315.0
48.04200	22.23	30.00	7.77	120.000	314.0	H	161.0
180.9320	20.67	33.52	12.85	120.000	100.0	V	229.0
218.3740	17.71	36.02	18.31	120.000	125.0	V	137.0
296.9440	19.65	36.02	16.37	120.000	287.0	H	71.0
479.9830	25.47	36.02	10.55	120.000	187.0	H	251.0

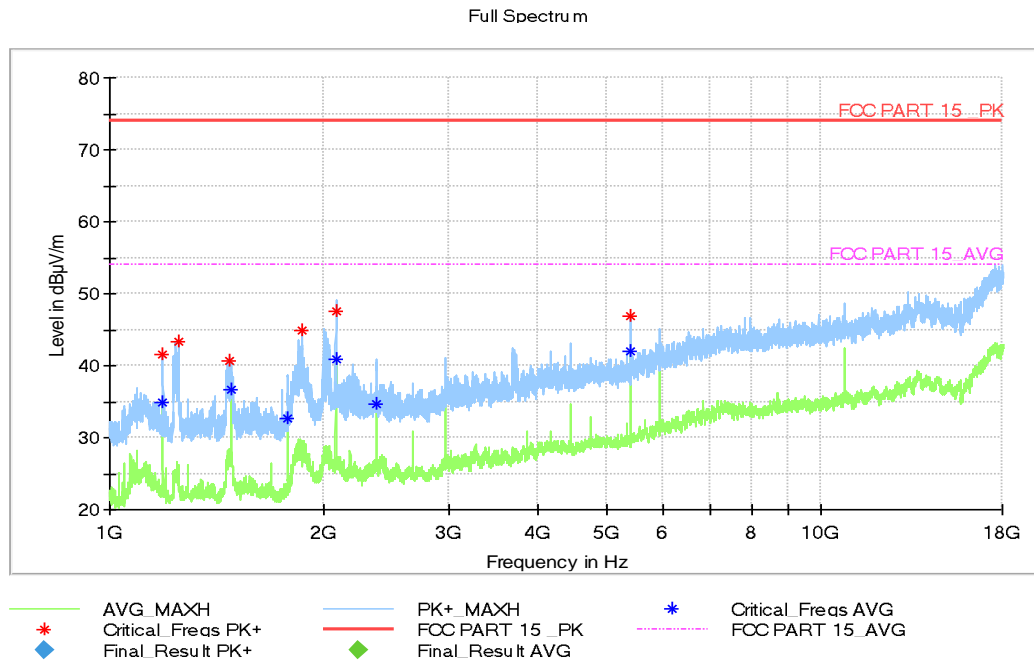


Figure A.4 Radiated Emission from 1GHz to 18GHz

Average detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
5399.940000	42.10	54.00	11.90	1000.000	100.0	V	90.0
2375.980000	34.68	54.00	19.32	1000.000	100.0	H	0.0
2078.820000	40.90	54.00	13.10	1000.000	100.0	V	0.0
1187.680000	34.99	54.00	19.01	1000.000	200.0	H	90.0
1484.840000	36.65	54.00	17.35	1000.000	100.0	V	270.0
1782.000000	32.76	54.00	21.24	1000.000	200.0	V	180.0

Peak detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
1470.220000	40.68	74.00	33.32	1000.000	100.0	H	90.0
1188.020000	41.49	74.00	32.51	1000.000	200.0	H	90.0
1247.520000	43.37	74.00	30.63	1000.000	100.0	V	90.0
1862.580000	44.93	74.00	29.07	1000.000	200.0	H	0.0
5399.940000	46.94	74.00	27.06	1000.000	100.0	V	90.0
2078.480000	47.52	74.00	33.32	1000.000	100.0	H	90.0

Set.3

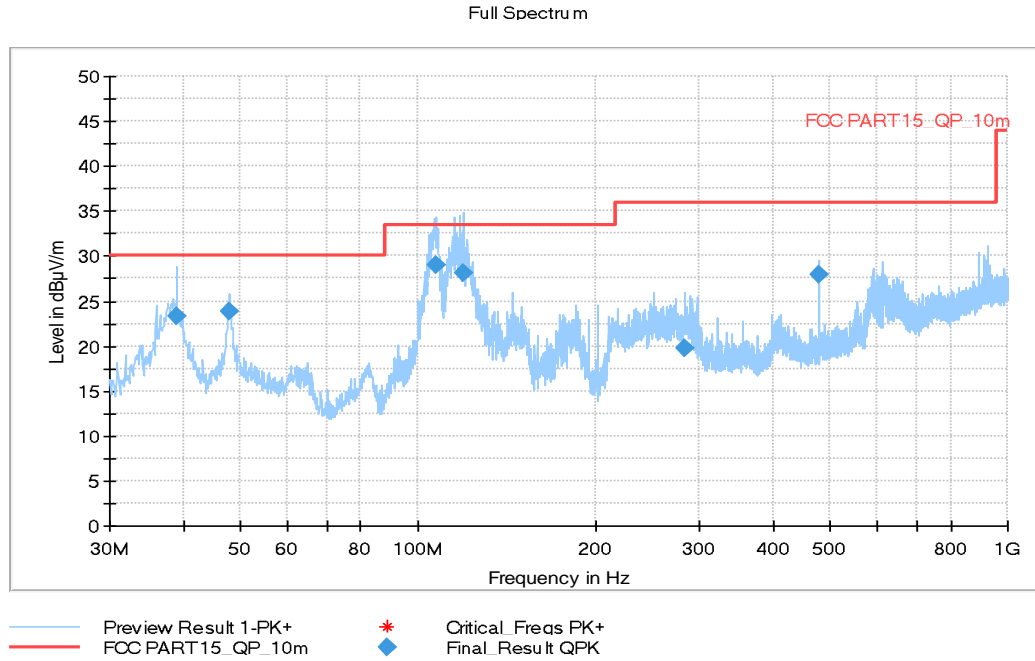


Figure A.5 Radiated Emission from 30MHz to 1GHz

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)
39.02100	23.24	30.00	6.76	120.000	100.0	V	74.0
47.94500	23.79	30.00	6.21	120.000	325.0	H	228.0
107.2120	29.06	33.52	4.46	120.000	100.0	V	50.0
119.24000	28.15	33.52	5.37	120.000	125.0	V	25.0
283.2670	19.75	36.02	16.27	120.000	100.0	V	211.0
479.9830	27.89	36.02	8.13	120.000	275.0	V	211.0

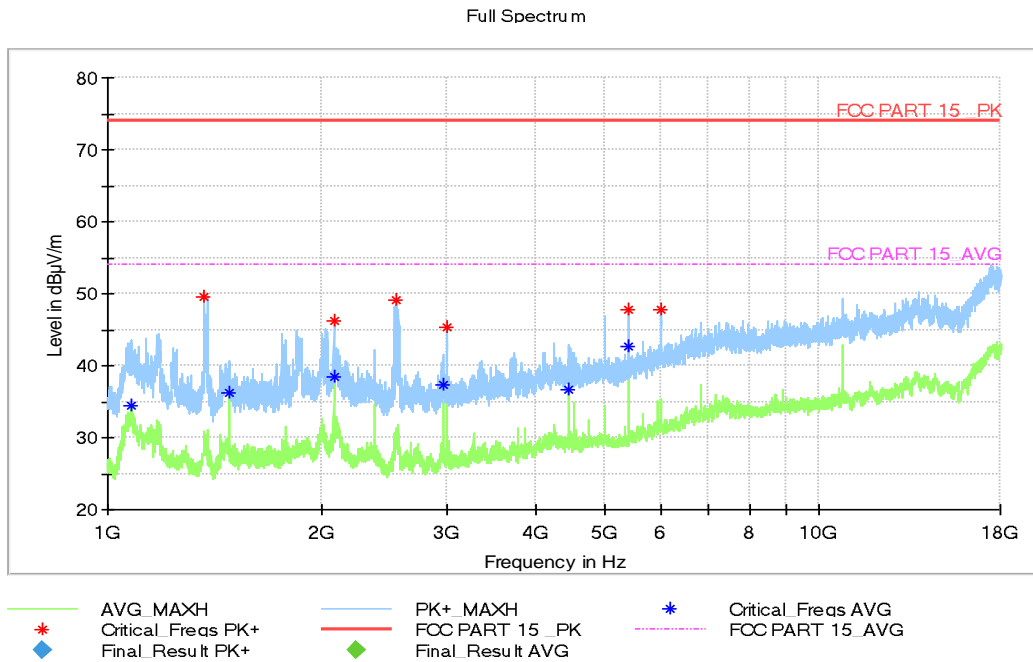


Figure A.6 Radiated Emission from 1GHz to 18GHz

Average detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
5399.940000	42.65	54.00	11.35	1000.000	100.0	V	90.0
1079.560000	34.55	54.00	19.45	1000.000	100.0	V	90.0
4455.080000	36.63	54.00	17.37	1000.000	200.0	H	0.0
2078.820000	38.37	54.00	15.63	1000.000	100.0	H	90.0
2969.960000	37.23	54.00	16.77	1000.000	100.0	V	270.0
1484.840000	36.19	54.00	17.81	1000.000	200.0	V	270.0

Peak detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
2994.780000	45.43	74.00	28.57	1000.000	100.0	V	270.0
2079.160000	46.26	74.00	27.74	1000.000	100.0	H	90.0
5994.940000	47.71	74.00	26.29	1000.000	100.0	H	180.0
5400.280000	47.87	74.00	26.13	1000.000	100.0	V	90.0
2549.040000	49.13	74.00	24.87	1000.000	200.0	H	90.0
1369.240000	49.54	74.00	24.46	1000.000	100.0	V	180.0

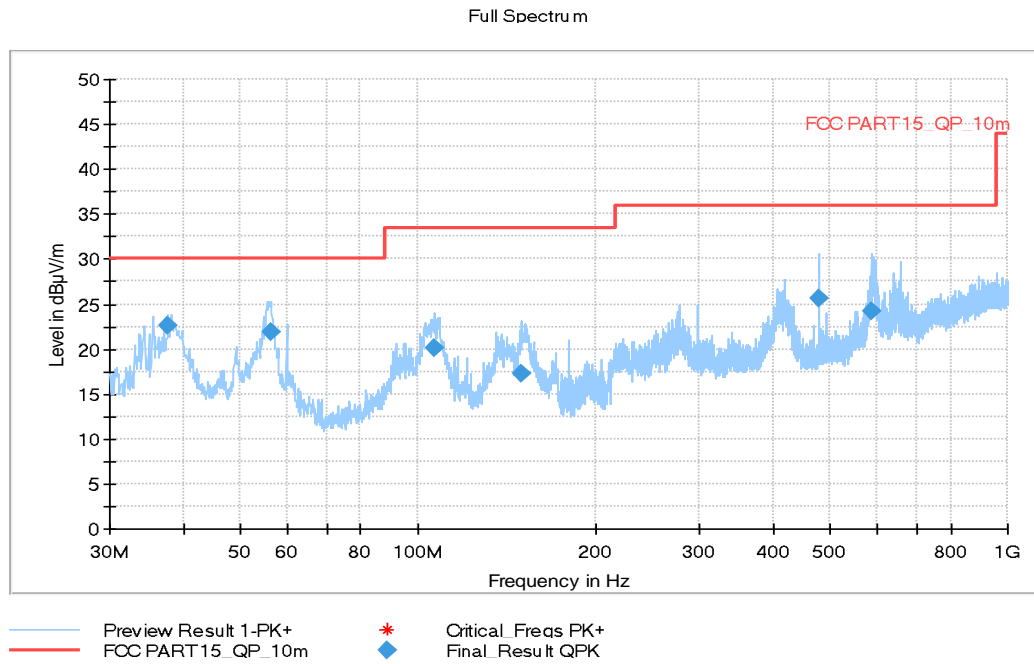
Set.4


Figure A.7 Radiated Emission from 30MHz to 1GHz

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Polarization	Azimuth (deg)
37.76000	22.55	30.00	7.45	120.000	225.0	V	270.0
56.38400	21.91	30.00	8.09	120.000	286.0	H	149.0
106.6300	20.09	33.52	13.43	120.000	125.0	V	229.0
150.0860	17.32	33.52	16.20	120.000	125.0	V	176.0
479.9830	25.58	36.02	10.44	120.000	275.0	V	149.0
588.9140	24.18	36.02	11.84	120.000	202.0	V	9.0

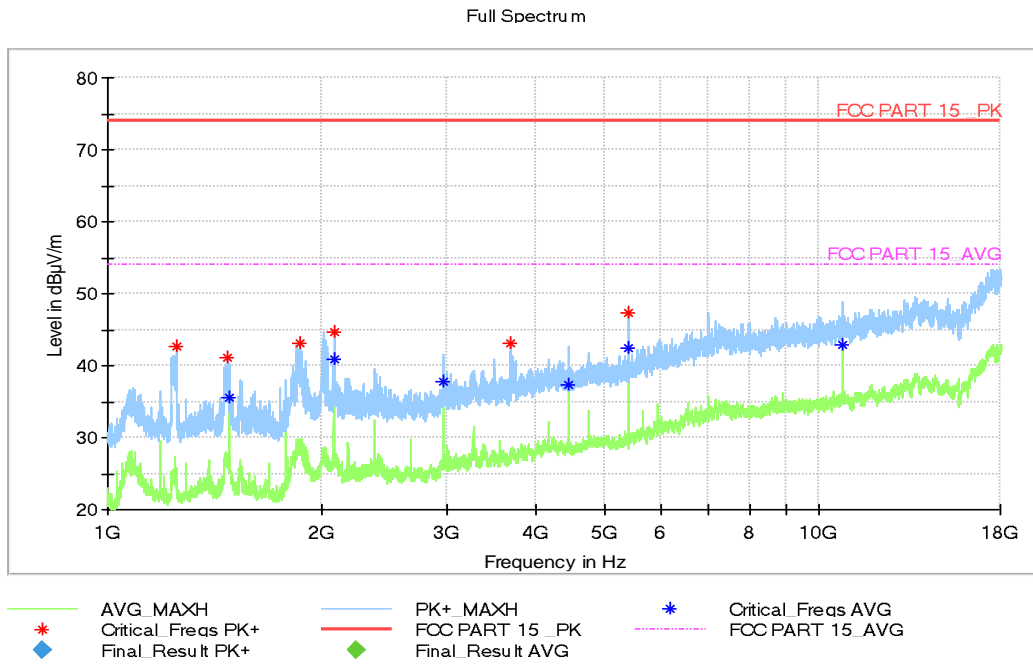


Figure A.8 Radiated Emission from 1GHz to 18GHz

Average detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
5400.620000	42.48	54.00	11.52	1000.000	100.0	H	0.0
10801.520000	42.93	54.00	11.07	1000.000	100.0	V	90.0
4455.080000	37.28	54.00	16.72	1000.000	100.0	V	180.0
2078.820000	40.93	54.00	13.07	1000.000	200.0	V	180.0
2969.960000	37.68	54.00	16.32	1000.000	200.0	V	270.0
1484.840000	35.47	54.00	18.53	1000.000	100.0	V	90.0

Peak detector result

Frequency (MHz)	Measurement Result (dBµV/m)	Limit (dBµV/m)	Margin (dB)	Bandwidth (kHz)	Height (cm)	Pol	Azimuth (deg)
1470.560000	41.09	74.00	32.91	1000.000	100.0	V	90.0
1246.840000	42.58	74.00	31.42	1000.000	100.0	V	90.0
1860.200000	43.18	74.00	30.82	1000.000	200.0	H	0.0
3684.640000	43.20	74.00	30.80	1000.000	100.0	H	0.0
2078.820000	44.65	74.00	29.35	1000.000	200.0	V	180.0
5400.280000	47.36	74.00	32.91	1000.000	100.0	V	90.0

A.2 Conducted Emission

Reference

FCC: CFR Part 15.107(a).

A.2.1 Method of measurement

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies within the band 150 kHz to 30 MHz shall not exceed the limits. Tested in accordance with the procedures of ANSI C63.4 – 2014, section 7.3.

For the test setup photographs please see the test setup photos document.

A.2.2 EUT Operating Mode

The EUT exercise program was tested using the Burn-in test program for windows.

The system was configured for testing in a typical mode that a customer would normal use.

Cables were attached to each of the available I/O ports. Where applicable, peripherals were attached to the I/O cables. All the external I/O ports were exercised.

LABTM software is used to let the EUT to continuously copy data to external (Hard Disk & SD card) storage media, read and erase the data after copy action was finished. During the test, the a pattern of “H” characters was written to display on the LCD panel; the camera was in video mode; the music was repetitively played through the headset; the WIFI and BT function was on and worked in receiver mode.

A.2.3 Measurement Limit

Frequency of emission (MHz)	Conducted limit (dBμV)	
	Quasi-peak	Average
0.15-0.5	66 to 56*	56 to 46*
0.5-5	56	46
5-30	60	50

*Decreases with the logarithm of the frequency

A.2.4 Test Condition in charging mode

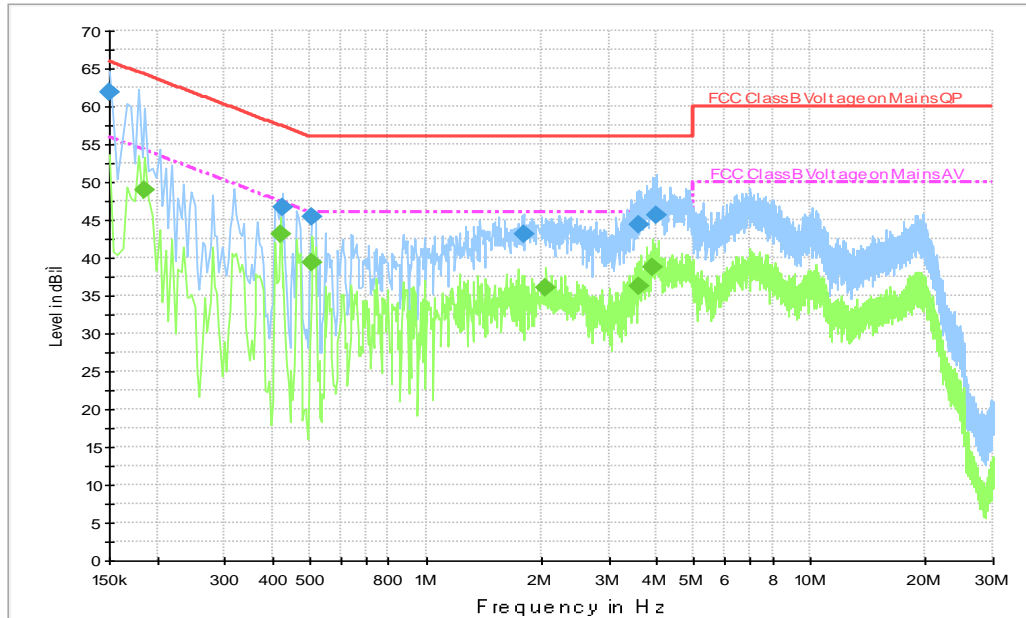
Voltage (V)	Frequency (Hz)
120	60

RBW/IF bandwidth	Sweep Time(s)
9kHz	1

A.2.5 Measurement Results

Measurement uncertainty: $U= 3.08 \text{ dB}$, $k=2$.

Set.1



Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

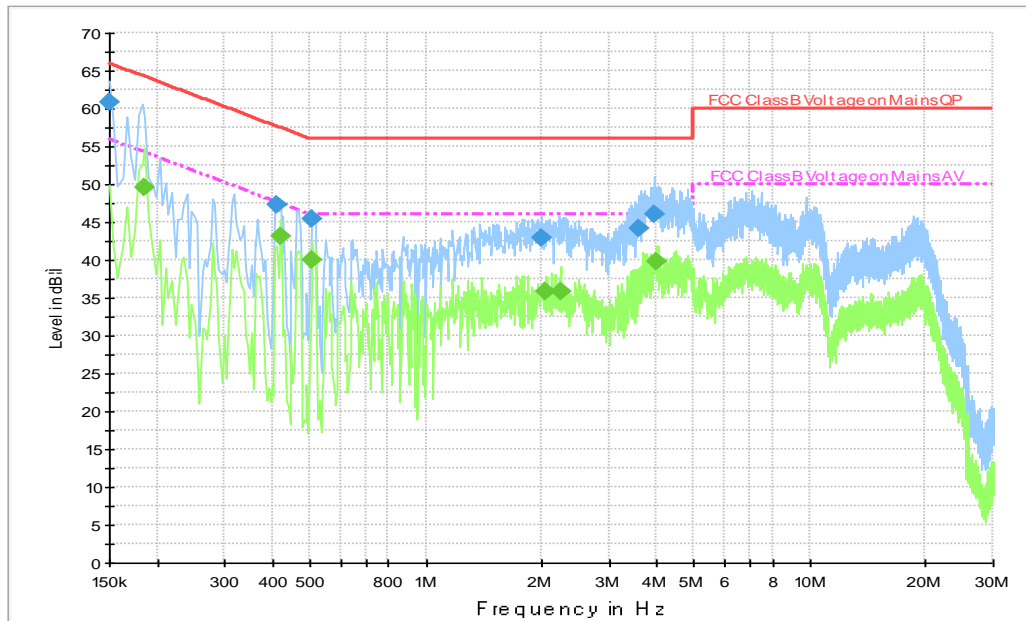
Figure A.9 Conducted Emission

Final Result 1

Frequency (MHz)	QuasiPeak (dBμV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBμV)
0.150000	61.9	5000.0	9.000	On	L1	20.0	4.1	66.0
0.426000	46.6	5000.0	9.000	On	L1	19.7	10.7	57.3
0.506000	45.5	5000.0	9.000	On	L1	19.7	10.5	56.0
1.794000	43.1	5000.0	9.000	On	L1	19.6	12.9	56.0
3.574000	44.3	5000.0	9.000	On	N	19.6	11.7	56.0
3.974000	45.7	5000.0	9.000	On	N	19.6	10.3	56.0

Final Result 2

Frequency (MHz)	Average (dBμV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBμV)
0.186000	48.9	5000.0	9.000	On	N	19.7	5.3	54.2
0.418000	43.2	5000.0	9.000	On	L1	19.7	4.3	47.5
0.506000	39.3	5000.0	9.000	On	L1	19.7	6.7	46.0
2.058000	35.9	5000.0	9.000	On	L1	19.6	10.1	46.0
3.590000	36.2	5000.0	9.000	On	N	19.6	9.8	46.0
3.890000	38.7	5000.0	9.000	On	N	19.6	7.3	46.0

Set.2


Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

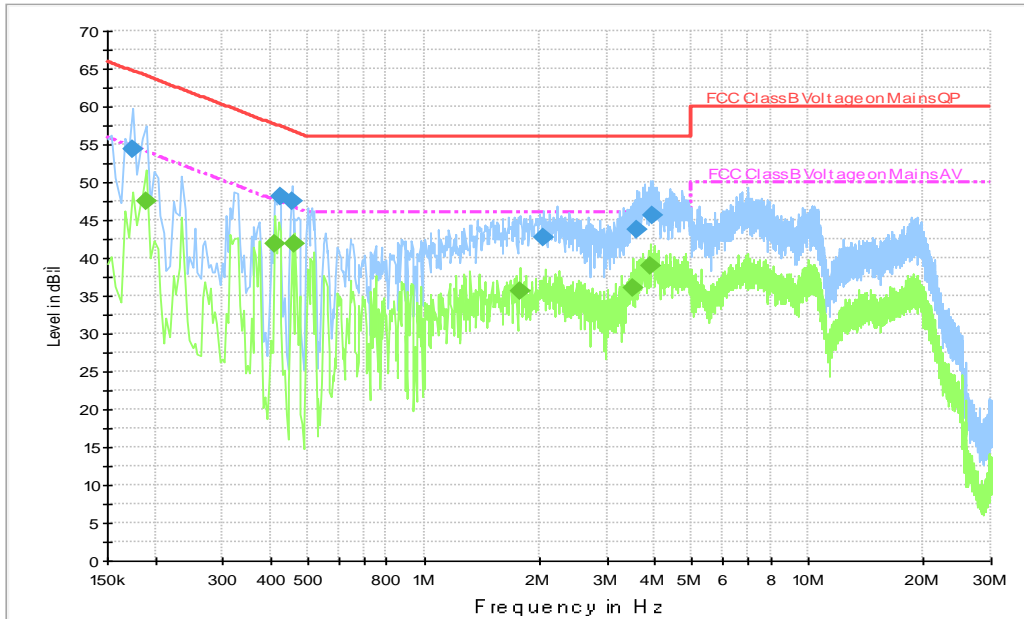
Figure A.10 Conducted Emission

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.150000	60.9	5000.0	9.000	On	L1	20.0	5.1	66.0
0.410000	47.2	5000.0	9.000	On	L1	19.7	10.5	57.6
0.506000	45.4	5000.0	9.000	On	L1	19.7	10.6	56.0
1.994000	42.9	5000.0	9.000	On	L1	19.6	13.1	56.0
3.578000	44.2	5000.0	9.000	On	N	19.6	11.8	56.0
3.950000	46.0	5000.0	9.000	On	N	19.6	10.0	56.0

Final Result 2

Frequency (MHz)	Average (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.186000	49.6	5000.0	9.000	On	N	19.7	4.6	54.2
0.418000	43.0	5000.0	9.000	On	L1	19.7	4.5	47.5
0.506000	40.0	5000.0	9.000	On	L1	19.7	6.0	46.0
2.058000	35.9	5000.0	9.000	On	L1	19.6	10.1	46.0
2.242000	35.9	5000.0	9.000	On	N	19.6	10.1	46.0
3.970000	39.8	5000.0	9.000	On	N	19.6	6.2	46.0

Set.3


Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

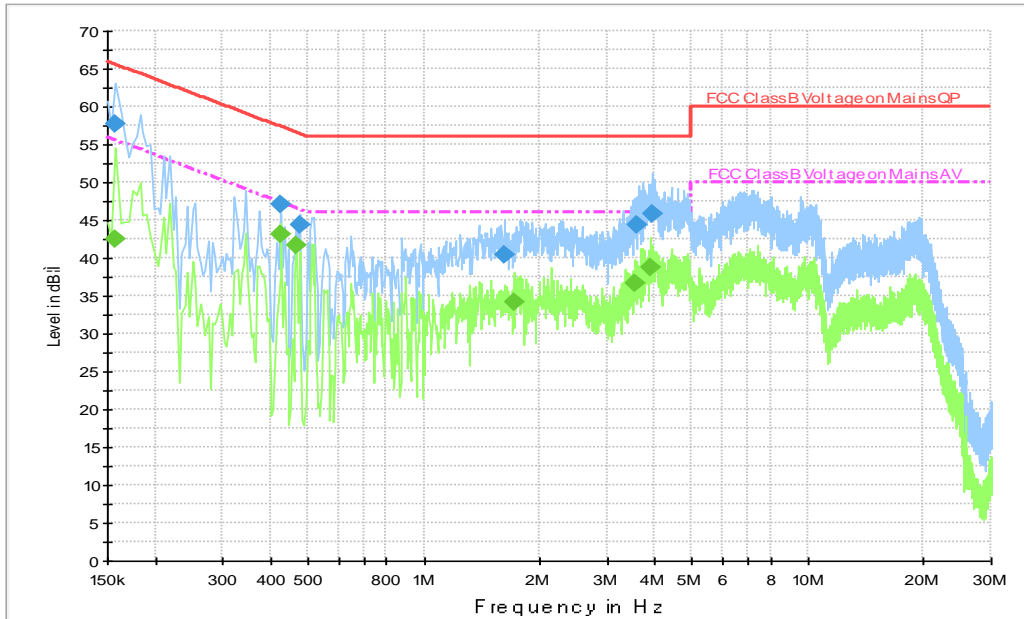
Figure A.11 Conducted Emission

Final Result 1

Frequency (MHz)	QuasiPeak (dBμV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBμV)
0.174000	54.3	5000.0	9.000	On	N	19.7	10.5	64.8
0.422000	48.2	5000.0	9.000	On	L1	19.7	9.2	57.4
0.454000	47.5	5000.0	9.000	On	N	19.7	9.3	56.8
2.046000	42.7	5000.0	9.000	On	L1	19.6	13.3	56.0
3.586000	43.8	5000.0	9.000	On	N	19.6	12.2	56.0
3.930000	45.6	5000.0	9.000	On	N	19.6	10.4	56.0

Final Result 2

Frequency (MHz)	Average (dBμV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBμV)
0.190000	47.6	5000.0	9.000	On	N	19.7	6.5	54.0
0.410000	42.0	5000.0	9.000	On	L1	19.7	5.7	47.6
0.462000	41.9	5000.0	9.000	On	N	19.7	4.8	46.7
1.782000	35.6	5000.0	9.000	On	L1	19.6	10.4	46.0
3.514000	36.0	5000.0	9.000	On	N	19.6	10.0	46.0
3.902000	38.9	5000.0	9.000	On	N	19.6	7.1	46.0

Set.4


Note: The graphic result above is the maximum of the measurements for both phase line and neutral line.

Figure A.12 Conducted Emission

Final Result 1

Frequency (MHz)	QuasiPeak (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.158000	57.7	5000.0	9.000	On	N	19.7	7.9	65.6
0.426000	47.1	5000.0	9.000	On	L1	19.7	10.3	57.3
0.474000	44.3	5000.0	9.000	On	N	19.7	12.1	56.4
1.622000	40.5	5000.0	9.000	On	L1	19.6	15.5	56.0
3.598000	44.3	5000.0	9.000	On	N	19.6	11.7	56.0
3.950000	45.8	5000.0	9.000	On	N	19.6	10.2	56.0

Final Result 2

Frequency (MHz)	Average (dBµV)	Meas. Time (ms)	Bandwidth (kHz)	Filter	Line	Corr. (dB)	Margin (dB)	Limit (dBµV)
0.158000	42.4	5000.0	9.000	On	N	19.7	13.1	55.6
0.426000	43.0	5000.0	9.000	On	L1	19.7	4.3	47.3
0.466000	41.6	5000.0	9.000	On	N	19.7	5.0	46.6
1.710000	34.2	5000.0	9.000	On	L1	19.6	11.8	46.0
3.542000	36.6	5000.0	9.000	On	N	19.6	9.4	46.0
3.906000	38.7	5000.0	9.000	On	N	19.6	7.3	46.0

ANNEX B: Persons involved in this testing

Test Item	Tester
Radiated Emission	DING Zai, ZHANG Tianli, LI Pengfei, Yan Hanchen
Conducted Emission	ZHANG Tianli, Chen Tianwei

*****END OF REPORT*****